

Notice of References Cited

Application/Control No.

09/642,416

Applicant(s)/Patent Under
Reexamination
LAIN ET AL.

Examiner

Thomas D. Lee

Art Unit

2624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,331,898	12-2001	Yokoi et al.	358/1.9
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NON-PATENT DOCUMENTS

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